

MOSFETs Silicon N-channel MOS (U-MOSIX-H)

# SSM6K514NU

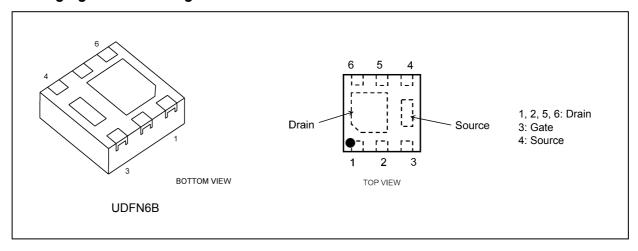
### 1. Applications

· Power Management Switches

#### 2. Features

- (1) 4.5 V drive
- (2) Low drain-source on-resistance
  - :  $R_{DS(ON)}$  = 11.2 m $\Omega$  (typ.) (@V<sub>GS</sub> = 4.5 V)  $R_{DS(ON)}$  = 8.9 m $\Omega$  (typ.) (@V<sub>GS</sub> = 10 V)

## 3. Packaging and Pin Assignment





## 4. Absolute Maximum Ratings (Note) (Unless otherwise specified, Ta = 25°C)

| Characteristics               |            |          |                  | Rating     | Unit |
|-------------------------------|------------|----------|------------------|------------|------|
| Drain-source voltage          |            |          | V <sub>DSS</sub> | 40         | V    |
| Gate-source voltage           |            |          | V <sub>GSS</sub> | ±20        |      |
| Drain current (DC)            |            |          | I <sub>D</sub>   | 12         | Α    |
| Drain current (pulsed)        |            | (Note 1) | I <sub>DP</sub>  | 50         |      |
| Power dissipation             |            | (Note 2) | P <sub>D</sub>   | 1.25       | W    |
| Power dissipation             | (t ≤ 10 s) | (Note 2) |                  | 2.5        |      |
| Single-pulse avalanche energy |            | (Note 3) | E <sub>AS</sub>  | 49.1       | mJ   |
| Avalanche current             |            |          | I <sub>AR</sub>  | 7          | Α    |
| Channel temperature           |            |          | T <sub>ch</sub>  | 150        | ℃    |
| Storage temperature           |            |          | T <sub>stg</sub> | -55 to 150 |      |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width (PW)  $\leq$  10  $\mu$ s, duty = 1 %

Note 2: Device mounted on a FR4 board.

 $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{ mm}, \text{Cu Pad: } 645 \text{ mm}^2)$ 

Note 3:  $V_{DD}$  = 32 V,  $T_{ch}$  = 25 °C (Initial state), L = 1 mH,  $R_G$  = 25  $\Omega$ 

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance,  $R_{th(ch-a)}$ , and the drain power dissipation,  $P_D$ , vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.



#### 5. Electrical Characteristics

## 5.1. Static Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

| Characteristics                |          | Symbol               | Test Condition                                    | Min | Тур. | Max  | Unit |
|--------------------------------|----------|----------------------|---|-----|------|------|------|
| Gate leakage current           |          | I <sub>GSS</sub>     | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | _   | _    | ±100 | nA   |
| Drain cut-off current          |          | I <sub>DSS</sub>     | V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V     |     |      | 1    | μА   |
| Drain-source breakdown voltage |          | V <sub>(BR)DSS</sub> | $I_D$ = 10 mA, $V_{GS}$ = 0 V                     | 40  |      |      | V    |
| Drain-source breakdown voltage | (Note 1) | V <sub>(BR)DSX</sub> | $I_D$ = 10 mA, $V_{GS}$ = -20 V                   | 37  |      |      |      |
| Gate threshold voltage         | (Note 2) | $V_{th}$             | $V_{DS} = 10 \text{ V}, I_D = 0.1 \text{ mA}$     | 1.4 |      | 2.4  |      |
| Drain-source on-resistance     | (Note 3) | R <sub>DS(ON)</sub>  | $I_D = 4 A, V_{GS} = 4.5 V$                       |     | 11.2 | 17.3 | mΩ   |
|                                |          |                      | I <sub>D</sub> = 4 A, V <sub>GS</sub> = 10 V      | _   | 8.9  | 11.6 |      |
| Forward transfer admittance    | (Note 3) | Y <sub>fs</sub>      | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2 A      | _   | 6.8  | _    | S    |

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (0.1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

Take this into consideration when using the device.

Note 3: Pulse measurement.

## 5.2. Dynamic Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

| Characteristics                | Symbol           | Test Condition  | Min | Тур. | Max | Unit |
|--------------------------------|------------------|---|-----|------|-----|------|
| Input capacitance              | C <sub>iss</sub> | $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V},$                                      | _   | 1110 |     | pF   |
| Reverse transfer capacitance   | C <sub>rss</sub> | f = 1 MHz   |     | 26   |     |      |
| Output capacitance             | Coss             |   | _   | 245  |     |      |
| Switching time (turn-on time)  | t <sub>on</sub>  | $V_{DD}$ = 20 V, $I_{D}$ = 1.0 A<br>$V_{GS}$ = 0 to 4.5 V, $R_{GS}$ = 30 $\Omega$ , |     | 24   | 1   | ns   |
| Switching time (turn-off time) | t <sub>off</sub> | Duty $\leq$ 1 %, Input: $t_r$ , $t_f$ < 5 ns<br>Ground source, See Chapter 5.3      | _   | 35   |     |      |

#### 5.3. Switching Time Test Circuit

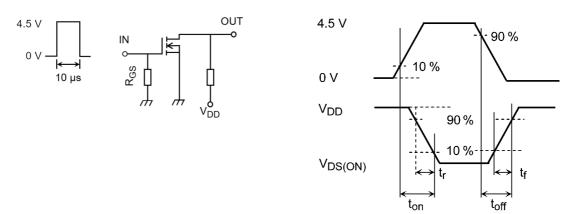


Fig. 5.3.1 Test Circuit of Switching Time

Fig. 5.3.2 Input Waveform/Output Waveform

### 5.4. Gate Charge Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

| Characteristics                                 | Symbol           | Test Condition                                   | Min | Тур. | Max | Unit |
|---|------------------|--|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | Qg               | $V_{DD} = 20 \text{ V}, V_{GS} = 4.5 \text{ V},$ | _   | 7.5  | _   | nC   |
| Gate-source charge 1                            | Q <sub>gs1</sub> | I <sub>D</sub> = 12 A                            | _   | 2.9  | _   |      |
| Gate-drain charge                               | Q <sub>gd</sub>  |  | _   | 2.8  | _   |      |

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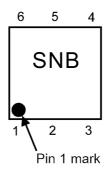


# 5.5. Source-Drain Characteristics (T<sub>a</sub> = 25°C unless otherwise specified)

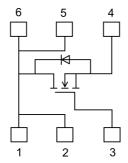
| Characteristics       |          | Symbol    | Test Condition                                 | Min | Тур. | Max | Unit |
|-----------------------|----------|-----------|--|-----|------|-----|------|
| Diode forward voltage | (Note 1) | $V_{DSF}$ | I <sub>DR</sub> = 4.0 A, V <sub>GS</sub> = 0 V | _   | 0.74 | 1.2 | V    |

Note 1: Pulse measurement.

### 6. Marking



### 7. Internal Circuit





#### 8. Characteristics Curves (Note)

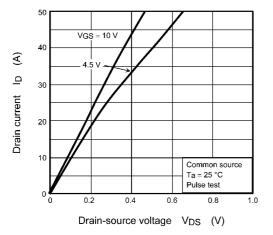


Fig. 8.1 I<sub>D</sub> - V<sub>DS</sub>

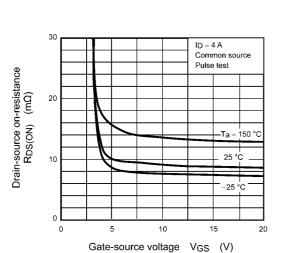


Fig. 8.3 R<sub>DS(ON)</sub> - V<sub>GS</sub>

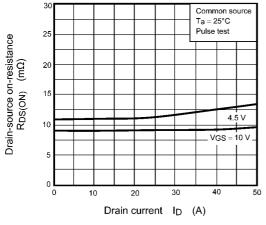


Fig. 8.5 R<sub>DS(ON)</sub> - I<sub>D</sub>

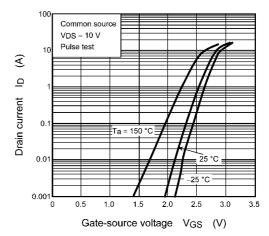


Fig. 8.2 I<sub>D</sub> - V<sub>GS</sub>

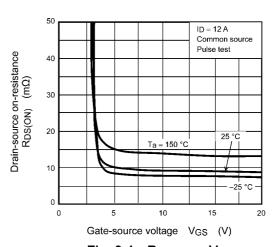


Fig. 8.4 R<sub>DS(ON)</sub> - V<sub>GS</sub>

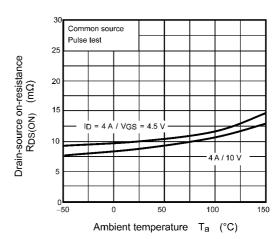


Fig. 8.6 R<sub>DS(ON)</sub> - T<sub>a</sub>



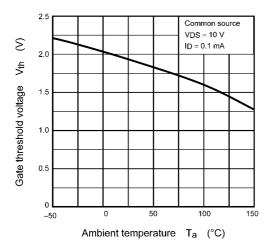


Fig. 8.7 V<sub>th</sub> - T<sub>a</sub>

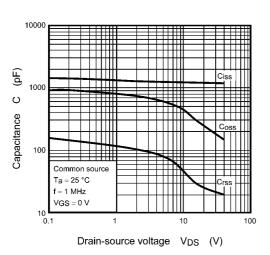


Fig. 8.9 C - V<sub>DS</sub>

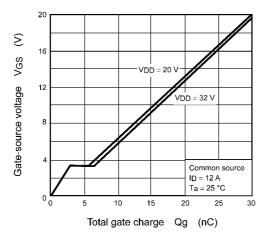


Fig. 8.11 Dynamic Input Characteristics

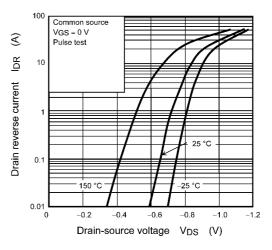


Fig. 8.8 I<sub>DR</sub> - V<sub>DS</sub>

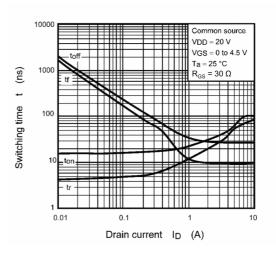


Fig. 8.10 t - I<sub>D</sub>

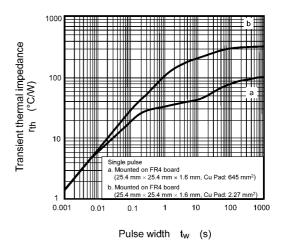


Fig. 8.12 rth - tw



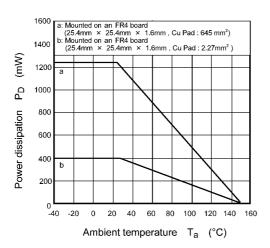


Fig. 8.13 P<sub>D</sub> - T<sub>a</sub>

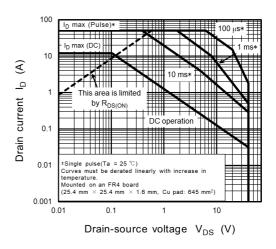


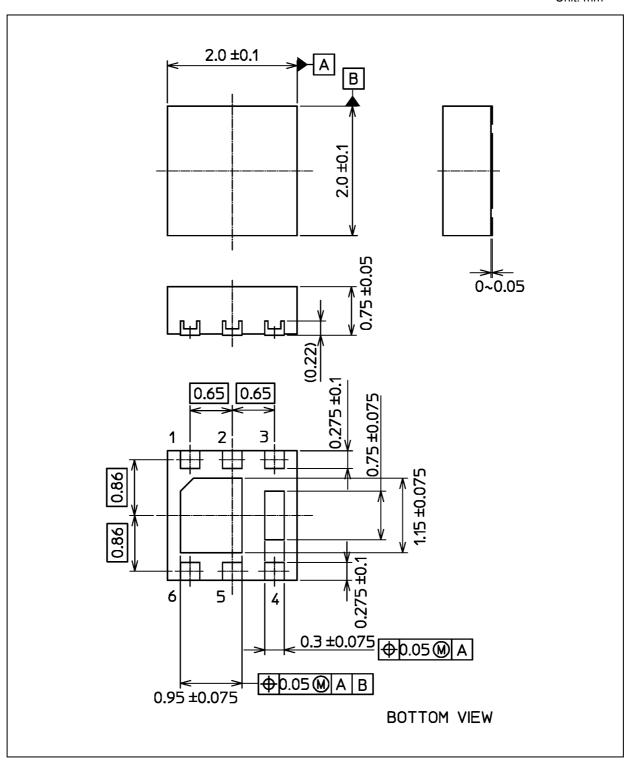
Fig. 8.14 Safe Operating Area

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



## **Package Dimensions**

Unit: mm



Weight: 8.5 mg (typ.)

| Package Name(s)  |  |
|------------------|--|
| JEDEC: SOT-1220  |  |
| Nickname: UDFN6B |  |

Rev.5.0



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